

Notice of References Cited	Application/Control No. 10/501,303	Applicant(s)/Patent Under Reexamination SEKIYA ET AL.	
	Examiner Mark Halpern	Art Unit 1791	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,306,814	10-2001	Appel et al.	510/446
*	B	US-6,267,842	07-2001	Ona et al.	162/135
*	C	US-2001/0037529	11-2001	Igarashi et al.	8/115.51
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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